



## **SPECIFICATION**

- Supplier : Samsung electro-mechanics
- Product : Multi-layer Ceramic Capacitor
- Samsung P/N : CL05C6R8CB5NNNC
- Description : CAP, 6.8pF, 50V, ±0.25pF, C0G, 0402

A. Samsung Part Number

	<u>CL</u>	<u>05</u> <u>C</u>		<u>C</u>	<u>B</u>	<u>5</u>	<u>N</u>	<u>N</u>	<u>N</u>	<u>C</u>	
	1	23	) (4)	(5)	6	0	8	9	10	1	
① Series	Samsung Multi-la	ayer Cera	mic Cap	acito	or						
② Size	0402 (inch c	ode)	L:	1.0	± 0.0	)5	mm		W:	$0.5 \pm 0.05 \text{ mm}$	
③ Dielectric	COG			8	Inne	r ele	ctroc	le		Ni	
Capacitance	<b>6.8</b> pF				Terr	ninat	tion			Cu	
<b>⑤</b> Capacitance	<b>±0.25</b> pF				Plat	ing				Sn 100% (Pb Free)	
tolerance				9	Proc	duct				Normal	
6 Rated Voltage	50 V			10	Spe	cial				Reserved for future use	
⑦ Thickness	0.5 ± 0.05	mm		1	Pac	kagir	ng			Cardboard Type, 7" reel	

## B. Samsung Reliablility Test and Judgement condition

	Performance	Test condition					
Capacitance	Within specified tolerance	1M±10% 0.5~5Vrms					
Q	536 min						
Insulation	10,000Mohm or 500Mohm ⋅ μF	Rated Voltage 60~120 sec.					
Resistance	Whichever is Smaller						
Appearance	No abnormal exterior appearance	Microscope (×10)					
Withstanding	No dielectric breakdown or	300% of the rated voltage					
Voltage	mechanical breakdown						
Temperature	C0G						
Characterisitcs	(From -55 $^\circ\!$						
Adhesive Strength	No peeling shall be occur on the	500g·F, for 10±1 sec.					
of Termination	terminal electrode						
Bending Strength	Capacitance change :	Bending to the limit (1mm)					
	within $\pm 5\%$ or $\pm 0.5$ pF whichever is larger	with 1.0mm/sec.					
Solderability More than 75% of terminal surface		SnAg3.0Cu0.5 solder					
is to be soldered newly		245±5℃, 3±0.3sec.					
		(preheating : 80~120℃ for 10~30sec.)					
Resistance to	Capacitance change :	Solder pot : 270±5℃, 10±1sec.					
Soldering heat	within $\pm 2.5\%$ or $\pm 0.25$ pF whichever is larger						
	Tan δ, IR : initial spec.						

	Performance	Test condition				
Vibration Test	Capacitance change :	Amplitude : 1.5mm				
	within $\pm 2.5\%$ or $\pm 0.25$ pF whichever is larger	From 10Hz to 55Hz (return : 1min.)				
	Tan δ, IR : initial spec.	2hours $\times$ 3 direction (x, y, z)				
Moisture	Capacitance change :	With rated voltage				
Resistance	within $\pm 7.5\%$ or $\pm 0.75$ pF whichever is larger	40±2℃, 90~95%RH, 500+12/-0hrs				
	Q : 122.67 min					
	IR : 500Mohm or 25Mohm $\cdot \mu F$					
	Whichever is Smaller					
High Temperature	Capacitance change :	With 200% of the rated voltage				
Resistance	within $\pm 3\%$ or $\pm 0.3$ pF whichever is larger	Max. operating temperature				
	Q : 268 min	1000+48/-0hrs				
	IR : 1000Mohm or 50Mohm $\cdot \mu F$					
	Whichever is Smaller					
Temperature	Capacitance change :	1 cycle condition				
Cycling	within $\pm 2.5\%$ or $\pm 0.25$ pF whichever is larger	Min. operating temperatur $\rightarrow$ 25 °C				
	Tan δ, IR : initial spec.	$ ightarrow$ Max. operating temperature $ ightarrow$ 25 $^\circ\!{ m C}$				
		5 cycle test				

## C. Recommended Soldering method :

Reflow ( Reflow Peak Temperature : 260+0/-5 °C, 10sec. Max )

\* For the more detail Specification, Please refer to the Samsung MLCC catalogue.